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<b>INFORMATION DISCLOSURE CITATION</b>  (Use several sheets if necessary)							
				Applicant(s) DOUGLAS BRISBIN, et al.			
				Filing Date Herewith		Group Unknown	
<b>U.S. PATENT DOCUMENTS</b>							
*Examiner Initials		Document Number	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						
	AC						
<b>FOREIGN PATENT DOCUMENTS</b>							
*Examiner Initials		Document Number	Date	Country	Class	Subclass	Translation YES    NO
	AD						
	AE						
	AF						
<b>OTHER DOCUMENTS</b>							
	AG	D. Brisbin, A. Strachan, and P. Chaparala, " <i>Breakdown Walk-in: A New PMOS Failure Mode in High Power BiCMOS Applications</i> ," presented at the IEEE 2003 International Integrated Reliability Workshop, at S. Lake Tahoe, California, on October 22, 2003, and published in the 2003 IEEE International Integrated Reliability Workshop Final Report (February 2004) (four pages)					
	AH						
	AI						
Examiner  				Date Considered  10/18/05			
* Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							